

<b>Notice of References Cited</b>	Application/Control No. 10/521,130	Applicant(s)/Patent Under Reexamination PINA, JEAN-BENOIT	
	Examiner CHARLES N. HICKS	Art Unit 2424	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0278737	12-2005	Ma et al.	725/040
*	B	US-2003/0122966	07-2003	Markman et al.	348/563
*	C	US-2003/0149978	08-2003	Plotnick, Bruce	725/39
*	D	US-2003/0106062	06-2003	Shteyn et al.	725/78
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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**NON-PATENT DOCUMENTS**

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